

Search Notes**Application/Control No.**

10/706,531

Examiner

Paul D. Kim

Applicant(s)/Patent under Reexamination

BASEMAN ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	603.07 603.13- 603.16 603.18	3/17/2006	PK
216	22.48 65		
360	316 324.1		
	324.11		
	324.12		
427	127 128		
451	5,41		
360	324.2	V	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search EAST/NPL (IEEE)	3/17/2006	PK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner